

IN THE U.S. PATENT AND TRADEMARK OFFICE

May 23, 2007

Applicants: Stefan FABER et al

For: MIXED METAL OXIDES AND USE THEREOF IN CO<sub>2</sub> SENSORS

Serial No.: 10/561 624 Group: 1754

Confirmation No.: 8459

Filed: May 15, 2006 Examiner: Bos

International Application No.: PCT/EP04/06938

International Filing Date: June 25, 2004

Atty. Docket No.: 5000.P0090US

Commissioner for Patents

P.O. Box 1450

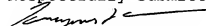
Alexandria, VA 22313-1450

**INFORMATION DISCLOSURE STATEMENT**

Sir:

In compliance with the provisions of Rules 1.97(b)(3) and 1.98, enclosed herewith is an Office Action of a parallel European application, Form PTO-1449 and the references cited thereon. EP 1 479 653 is cited in the European Office Action and U.S. patent publication 2004/0235640 is the corresponding U.S. application. They constitute the art known to the Applicants and are believed to be distinguishable from the claimed invention. Accordingly, further comment at this point in time should not be necessary.

Respectfully submitted,

  
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Encl: Form PTO-1449 and one copy of each listed reference

**CERTIFICATE OF MAILING**

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Assistant Commissioner for Patents, Washington, DC 20231 on May 23, 2007.

  
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INFORMATION DISCLOSURE CITATION	Applicant: Stefan FABER et al Ser.No.: 10/561 624 Conf. No.: 8459 Group: 1754	Filed: May 15, 2006 Atty. Docket No.: 5000.P0090US Date: May 23, 2007
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U.S. PATENT DOCUMENTS				
Examiner Initials*	Cite No.	Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant
Y.Q.J	AA	2004-0235640	11/25/2004	STERZEL
	AB			
	AC			
	AD			
	AE			
	AF			
	AG			
	AH			
	AI			
	AJ			
	AK			

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No.	Country Code - Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Trans.
/Y.Q./	AL	EP 1 479 653	11/24/2004	STERZEL	No
	AM				
	AN				
	AO				
	AP				

NON PATENT LITERATURE DOCUMENTS		
Examiner Initials*	Cite No.	(Include Author, Title, Date, Pages, Etc.)
/Y.Q./	AQ	European Office Action dated April 10, 2007
	AR	
EXAMINER SIGNATURE		DATE CONSIDERED
/Yun Qian/		09/15/2008

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.